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# **MOSFET** - Power, Single **N-Channel, PQFN8** 80 V, 32 A

## NTMFS006N08MC

#### **Features**

- Advanced Package (5x6mm) with Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

- Hot Swap Application
- Power Load Switch
- Battery Management and Protection

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltag	Gate-to-Source Voltage			±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	82	Α
Current R <sub>θJC</sub> (Note 3)	Steady	T <sub>C</sub> =85°C		59	
Power Dissipation $R_{\theta JC}$ (Note 3)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	78	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.7	Α
Current R <sub>θJA</sub> (Notes 1, 3)		T <sub>A</sub> = 85°C		10.6	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	2.5	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	9.3	Α
Current R <sub>θJA</sub> (Notes 2, 3)		T <sub>A</sub> = 85°C		6.7	
Power Dissipation R <sub>0</sub> JA (Notes 2, 3)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.0	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	216	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 32 A <sub>pk</sub> )			E <sub>AS</sub>	51	mJ
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

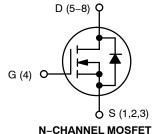
- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad, 2 oz Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	$6.0~\text{m}\Omega$ @ $10~\text{V}$	32 A
80 V	17 m $\Omega$ @ 6 V	16 A



## **MARKING DIAGRAMS**



**PQFN8** T1 SUFFIX CASE 483AE



= Assembly Location

= Year = Work Week = Lot Traceabililty

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{ heta JC}$	1.61	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	50	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	125	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu A$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA. ref to 25°C			96.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},   T_{J} = 25^{\circ}\text{C}$				1.0	
		V <sub>DS</sub> = 64 V	T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= 20 V			100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 200 μA. ref to 25°C			-5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 32 A		4.9	6.0	mΩ
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 6 V	I <sub>D</sub> = 16 A		10.2	17	mΩ
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C			0.3		Ω
CHARGES AND CAPACITANCES						•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V, f = 1 MHz			2300		pF
Output Capacitance	Coss				710		
Reverse Transfer Capacitance	C <sub>RSS</sub>				31		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 32 A			30		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.3		
Gate-to-Source Charge	Q <sub>GS</sub>				10		
Gate-to-Drain Charge	$Q_{GD}$				6.0		
SWITCHING CHARACTERISTICS (Note 7)						•	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 32 A, $R_{G}$ = 2.5 $\Omega$			13		ns
Rise Time	t <sub>r</sub>				4		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				18		
Fall Time	t <sub>f</sub>				4		
DRAIN-SOURCE DIODE CHARACTERISTI	cs						
Forward Diode Voltage	$V_{SD}$	v <sub>GS</sub> = 0 v,	T <sub>J</sub> = 25°C		0.84	1.2	.,,
					0.78		- V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 32 A			49.58		ns
Reverse Recovery Charge	Q <sub>RR</sub>				51.4		nC

<sup>6.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

Surface-mounted on FR4 board using 1 in<sup>2</sup> pad, 2 oz Cu pad.
Surface-mounted on FR4 board using minimum pad size, 2 oz Cu pad.

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

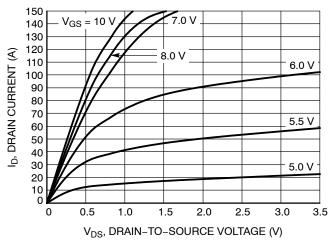


Figure 1. On-Region Characteristics

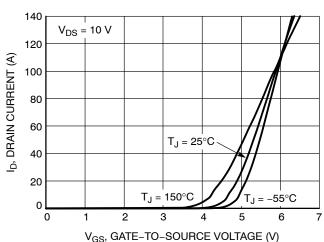


Figure 2. Transfer Characteristics

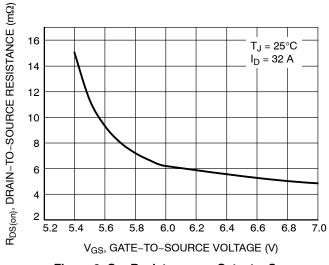


Figure 3. On-Resistance vs. Gate-to-Source Voltage

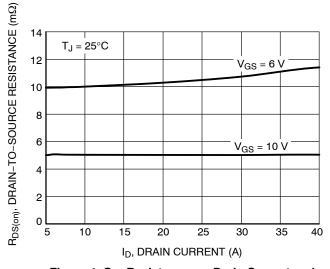


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

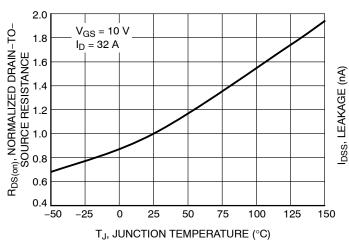


Figure 5. On–Resistance Variation with Temperature

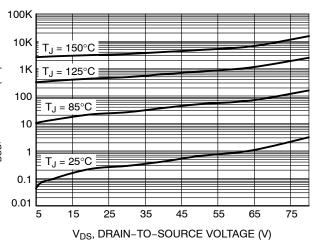


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

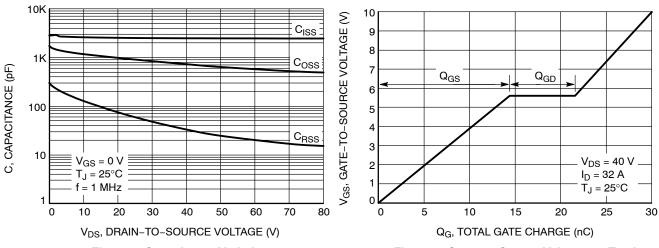


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total Charge

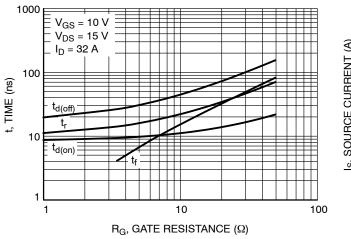


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

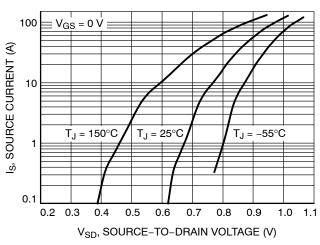


Figure 10. Diode Forward Voltage vs. Current

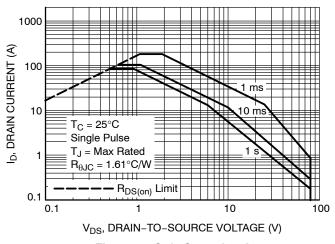


Figure 11. Safe Operating Area

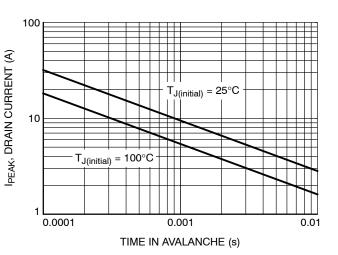


Figure 12. Maximum Drain Current vs. Time in Avalanche

## **TYPICAL CHARACTERISTICS**

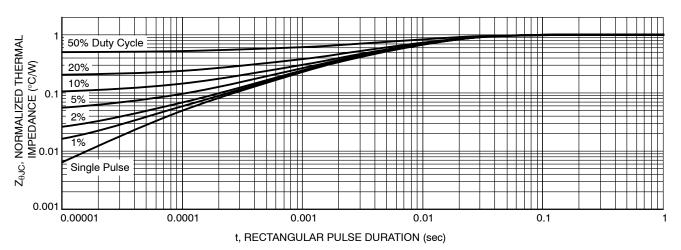


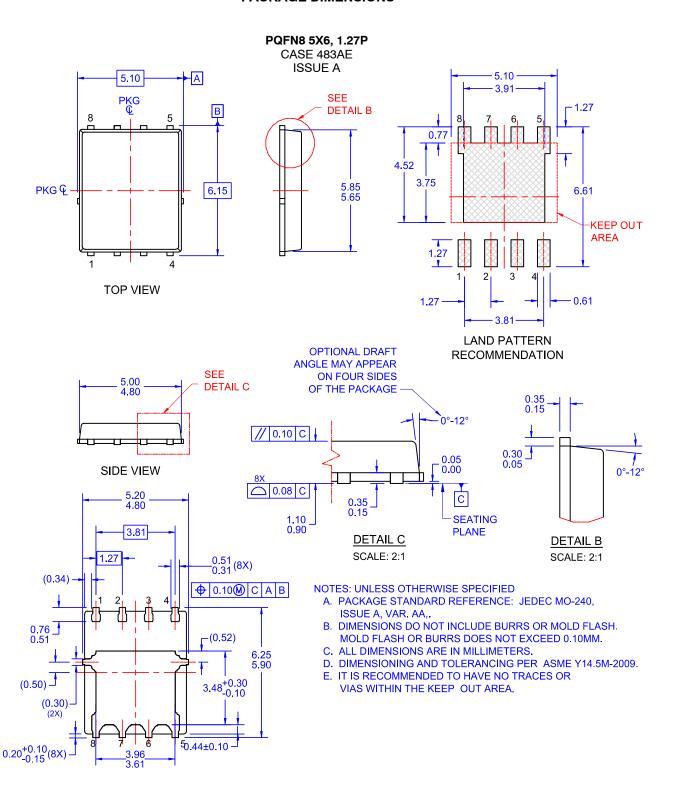
Figure 13. Transient Thermal Response

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFS006N08MC	06N08	PQFN8 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **PACKAGE DIMENSIONS**



**BOTTOM VIEW** 

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